

**Search Notes**

Application/Control No.

10/822,666

Examiner

VINH P. NGUYEN

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

2829

**SEARCHED**

Class	Subclass	Date	Examiner
324	754-765	5/20/2005	VN
439	482 824		
29	843 874		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR